

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	6	contour near3 filter\$4 same RGB near3 bayer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 11:58
S2	7	contour near3 filter\$4 same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/23 17:00
S3	8	contour near3 filter\$4 same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:01
S4	15	contour near3 filter\$4 and (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/23 17:40
S5	6196	382/167,162,242,266,210,211,260, 261,262,263,265;358/479;348/266, 267,272,273,222.1,231.99;386/117. ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/23 17:40
S6	99	(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD") same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/23 17:44
S7	38	S5 and(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD") same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 09:55
S8	6182	382/167,162,242,266,210,211,260, 261,262,263,265;358/479;348/266, 267,272,273,222.1,231.99;386/117. ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 09:55

S9	38	S8 and(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD") same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:12
S10	5	S9 and parallel near3 contour\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:09
S11	1	S9 and zero\$1 near3 miss\$3 near5 location	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:11
S12	1	S9 and (remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:18
S13	1	contour near3 filter\$4 same (remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:19
S14	1	contour near3 filter\$4 and (remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:23
S15	6	contour near3 filter\$4 and (prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:55
S16	2	S9 and (prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:26
S17	0	jaspers-maria.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:59

S18	0	jaspers-maria.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:57
S19	0	maria-jaspers.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:57
S20	14	jaspers-cornelis-antonie-maria.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 13:59
S21	3	S20 and (prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/24 14:00
S22	6	contour near3 filter\$4 same RGB near3 bayer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 11:59
S23	8	contour near3 filter\$4 same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:02
S24	6223	382/167,162,242,266,210,211,260, 261,262,263,265;358/479;348/266, 267,272,273,222.1,231.99;386/117. ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:26
S25	38	S24 and(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD") same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 13:09
S26	2	S25 and (prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:33
S27	2	S25 and (prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:34

S28	17	(prevent\$4 or remov\$4 or delect\$4 or extract\$4 tak\$4 adj1 out or cut adj1 out or expel\$4)same(green near5 non-uniformity or green adj1 difference\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 12:35
S29	5	S28 and(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD") same (RGB near3 bayer or green near5 non-uniformity or green adj1 difference\$1 or green adj1 uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 13:11
S30	9	S28 and(contour near3 filter\$4 or color near3 filter\$4 or color near3 sensor\$2 or "CCD")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/02 13:11

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